

FMV11N90E

FUJI POWER MOSFET

Super FAP-E³ series

N-CHANNEL SILICON POWER MOSFET

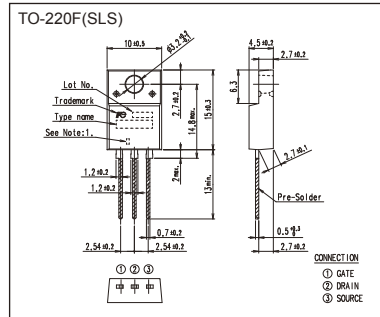
Features

- Maintains both low power loss and low noise
- Lower $R_{DS(on)}$ characteristic
- More controllable switching dV/dt by gate resistance
- Smaller V_{GS} ringing waveform during switching
- Narrow band of the gate threshold voltage ($4.0 \pm 0.5V$)
- High avalanche durability

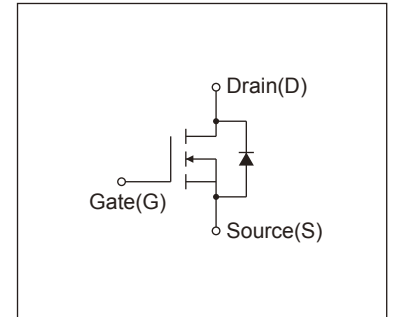
Applications

- Switching regulators
- UPS (Uninterruptible Power Supply)
- DC-DC converters

Outline Drawings [mm]



Equivalent circuit schematic



Maximum Ratings and Characteristics

Absolute Maximum Ratings at $T_c=25^\circ C$ (unless otherwise specified)

| Description | Symbol | Characteristics | Unit | Remarks |
|---|-----------|-----------------|-------------|------------------|
| Drain-Source Voltage | V_{DS} | 900 | V | |
| | V_{DSX} | 900 | V | $V_{GS} = -30V$ |
| Continuous Drain Current | I_D | ± 11 | A | |
| Pulsed Drain Current | I_{DP} | ± 44 | A | |
| Gate-Source Voltage | V_{GS} | ± 30 | V | |
| Repetitive and Non-Repetitive Maximum Avalanche Current | I_{AR} | 11 | A | Note*1 |
| Non-Repetitive Maximum Avalanche Energy | E_{AS} | 811.9 | mJ | Note*2 |
| Repetitive Maximum Avalanche Energy | E_{AR} | 12 | mJ | Note*3 |
| Peak Diode Recovery dV/dt | dV/dt | 2.2 | kV/ μs | Note*4 |
| Peak Diode Recovery $-di/dt$ | $-di/dt$ | 100 | A/ μs | Note*5 |
| Maximum Power Dissipation | P_D | 2.16 | W | $T_a=25^\circ C$ |
| | | 120 | | $T_c=25^\circ C$ |
| Operating and Storage Temperature range | T_{ch} | 150 | $^\circ C$ | |
| | T_{stg} | -55 to + 150 | $^\circ C$ | |

Electrical Characteristics at $T_c=25^\circ C$ (unless otherwise specified)

| Description | Symbol | Conditions | min. | typ. | max. | Unit |
|----------------------------------|--------------|---|------|------|------|----------|
| Drain-Source Breakdown Voltage | BV_{DSS} | $I_D=250\mu A, V_{GS}=0V$ | 900 | - | - | V |
| Gate Threshold Voltage | $V_{GS(th)}$ | $I_D=250\mu A, V_{DS}=V_{GS}$ | 3.5 | 4.0 | 4.5 | V |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS}=900V, V_{GS}=0V$ | - | - | 25 | μA |
| | | $V_{DS}=720V, V_{GS}=0V$ | - | - | 250 | |
| Gate-Source Leakage Current | I_{GSS} | $V_{GS}=\pm 30V, V_{DS}=0V$ | - | 10 | 100 | nA |
| Drain-Source On-State Resistance | $R_{DS(on)}$ | $I_D=5.5A, V_{GS}=10V$ | - | 0.83 | 1.0 | Ω |
| Forward Transconductance | g_{fs} | $I_D=5.5A, V_{DS}=25V$ | 6.5 | 13 | - | S |
| Input Capacitance | C_{iss} | $V_{DS}=25V$ | - | 2300 | 3450 | pF |
| Output Capacitance | C_{oss} | $V_{GS}=0V$ | - | 200 | 300 | |
| Reverse Transfer Capacitance | C_{rss} | $f=1MHz$ | - | 15 | 22.5 | |
| Turn-On Time | $t_{d(on)}$ | $V_{cc}=600V$ | - | 37 | 56 | ns |
| | t_r | $V_{GS}=10V$ | - | 32 | 48 | |
| Turn-Off Time | $t_{d(off)}$ | $I_D=5.5A$ | - | 124 | 186 | |
| | t_f | $R_G=20\Omega$ | - | 34 | 51 | |
| Total Gate Charge | Q_G | $V_{cc}=450V$ | - | 60 | 90 | nC |
| Gate-Source Charge | Q_{GS} | $I_D=11A$ | - | 17 | 26 | |
| Gate-Drain Charge | Q_{GD} | $V_{GS}=10V$ | - | 23 | 35 | |
| Gate-Drain Crossover Charge | Q_{SW} | | - | 7 | 11 | |
| Avalanche Capability | I_{AV} | $L=4.92mH, T_{ch}=25^\circ C$ | 11 | - | - | A |
| Diode Forward On-Voltage | V_{SD} | $I_F=11A, V_{GS}=0V, T_{ch}=25^\circ C$ | - | 0.90 | 1.35 | V |
| Reverse Recovery Time | t_{rr} | $I_F=11A, V_{GS}=0V$ | - | 2.0 | - | μs |
| Reverse Recovery Charge | Q_{rr} | $-di/dt=100A/\mu s, T_{ch}=25^\circ C$ | - | 20 | - | μC |

Thermal Characteristics

| Description | Symbol | Test Conditions | min. | typ. | max. | Unit |
|--------------------|----------------|--------------------|------|------|--------|--------------|
| Thermal resistance | $R_{th(ch-c)}$ | Channel to case | | | 1.0417 | $^\circ C/W$ |
| | $R_{th(ch-a)}$ | Channel to ambient | | | 58.0 | $^\circ C/W$ |

Note *1 : $T_{ch} \leq 150^\circ C$

Note *2 : Stating $T_{ch}=25^\circ C, I_{AS}=4.4A, L=76.9mH, V_{cc}=90V, R_G=10\Omega$
 E_{AS} limited by maximum channel temperature and avalanche current.
 See to 'Avalanche current' graph.

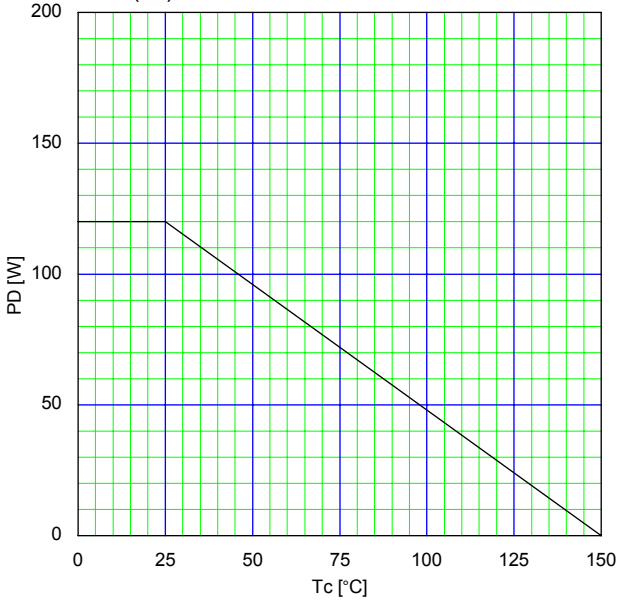
Note *3 : Repetitive rating : Pulse width limited by maximum channel temperature.

See to the 'Transient Thermal impedance' graph.

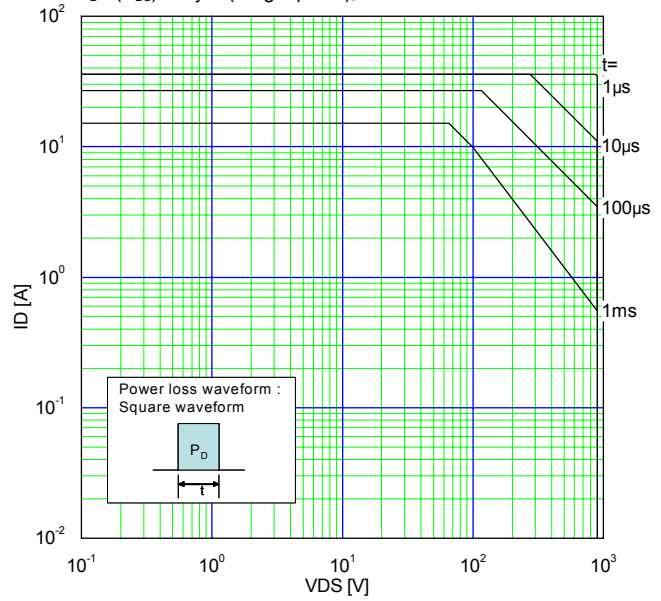
Note *4 : $I_F \leq I_D, -di/dt=100A/\mu s, V_{ccs}=BV_{DSS}, T_{ch} \leq 150^\circ C$.

Note *5 : $I_F \leq I_D, dv/dt=2.2kV/\mu s, V_{ccs}=BV_{DSS}, T_{ch} \leq 150^\circ C$.

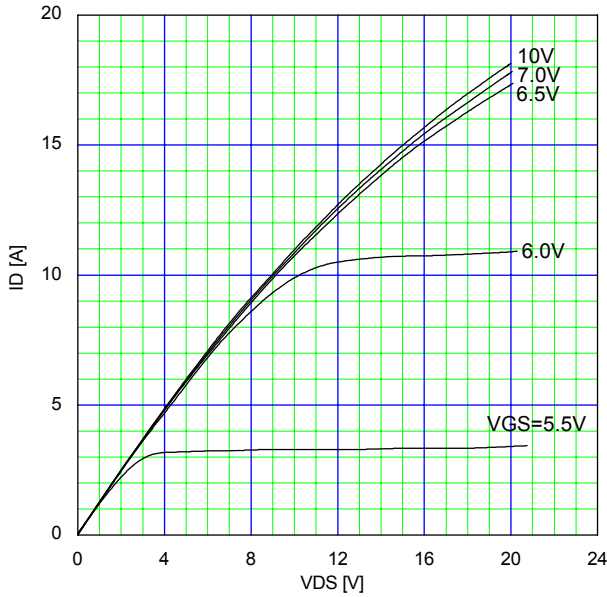
Allowable Power Dissipation
 $P_D = f(T_c)$



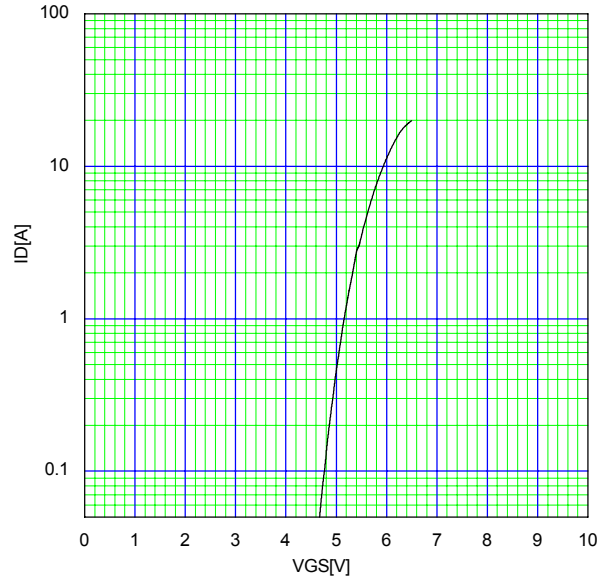
Safe Operating Area
 $I_D = f(V_{DS})$: Duty=0 (Single pulse), Tc=25°C



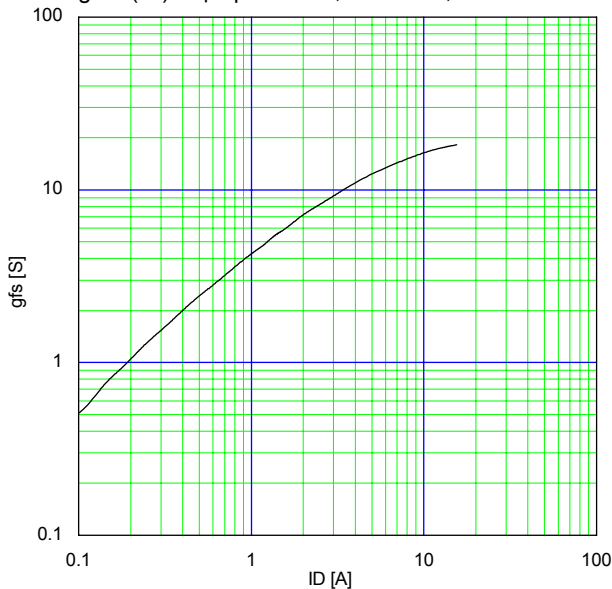
Typical Output Characteristics
 $I_D = f(V_{DS})$: 80 μs pulse test, Tch=25°C



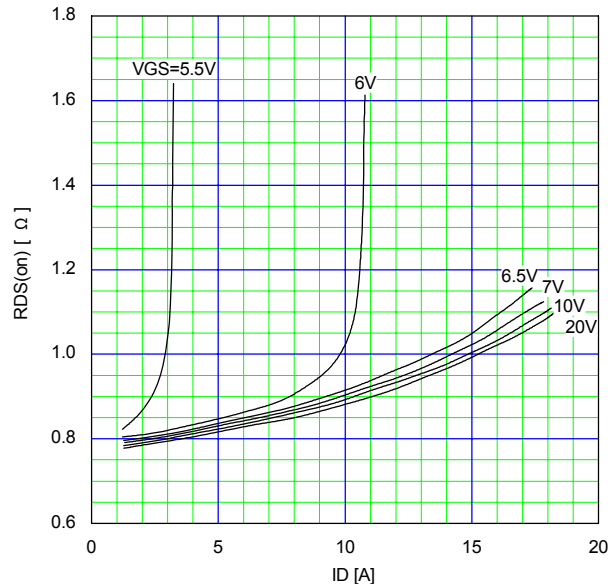
Typical Transfer Characteristic
 $I_D = f(V_{GS})$: 80 μs pulse test, VDS=25V, Tch=25°C

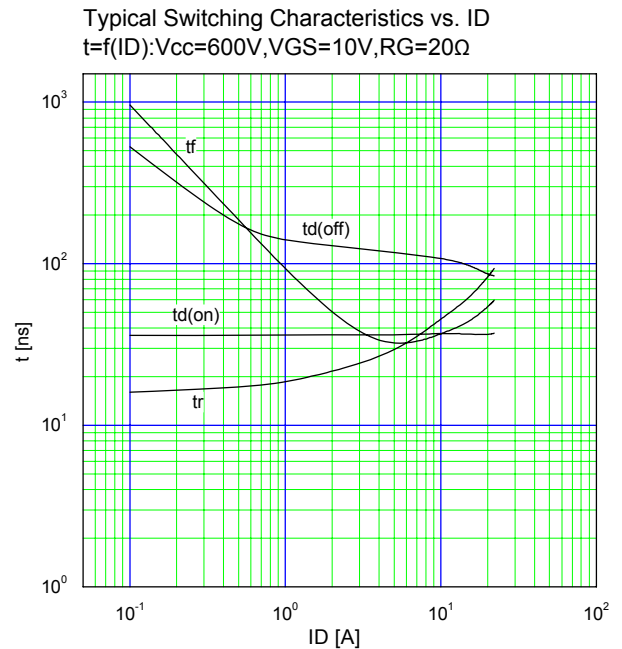
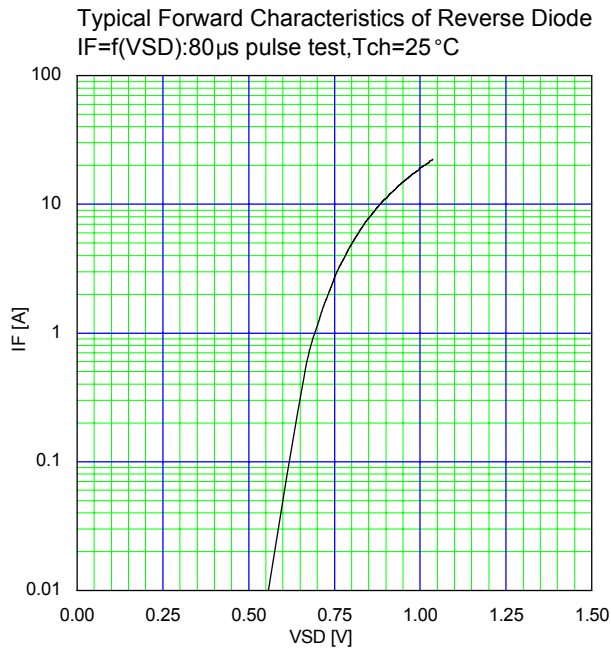
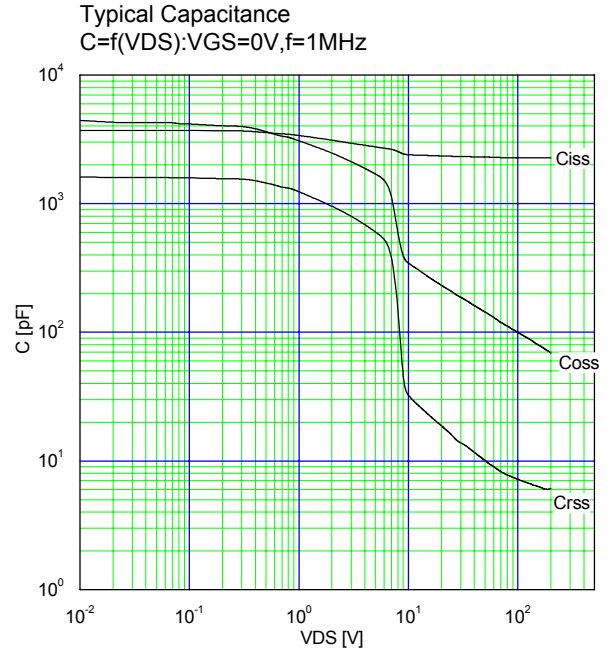
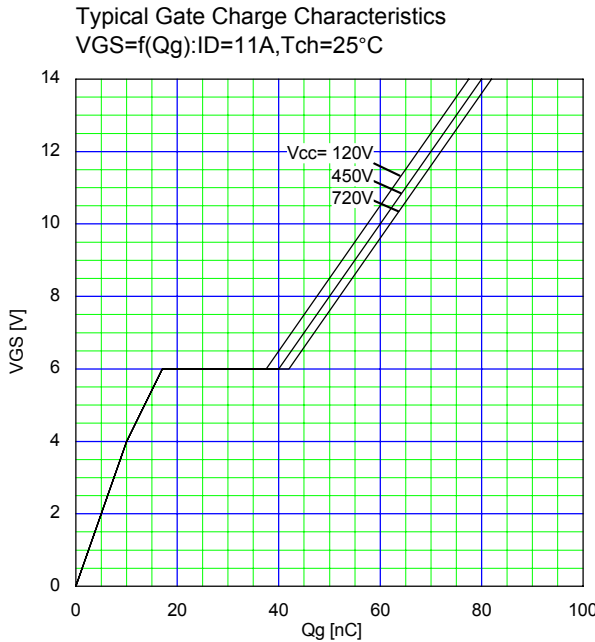
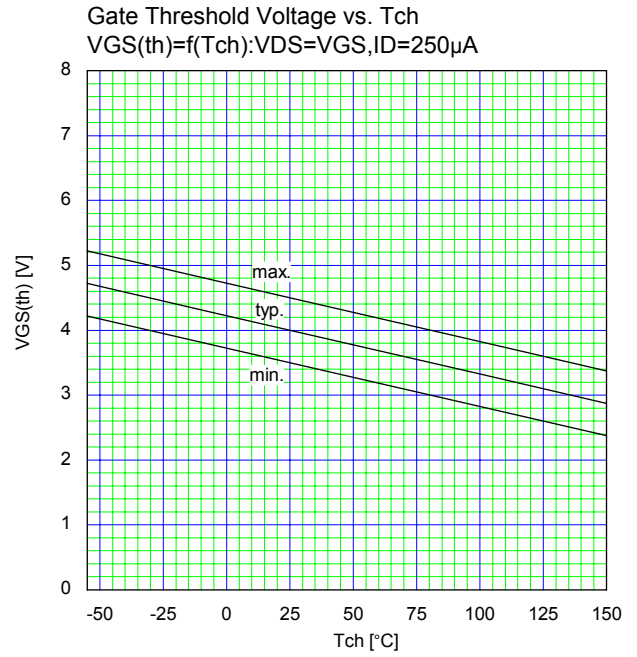
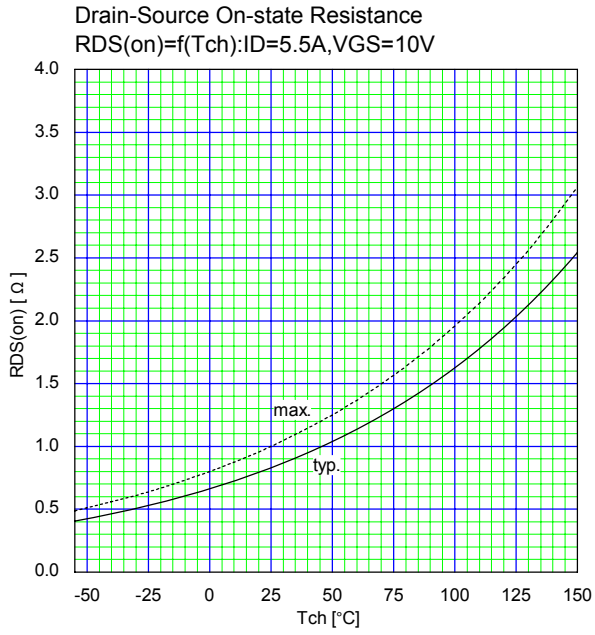


Typical Transconductance
 $g_{fs} = f(I_D)$: 80 μs pulse test, VDS=25V, Tch=25°C

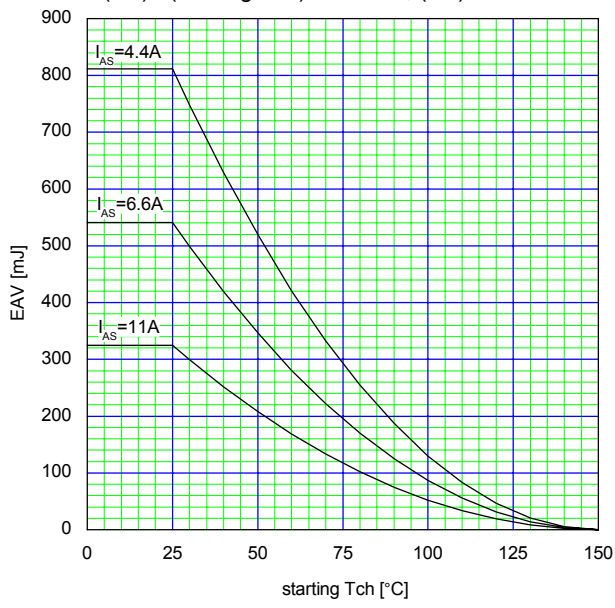


Typical Drain-Source on-state Resistance
 $R_{DS(on)} = f(I_D)$: 80 μs pulse test, Tch=25°C

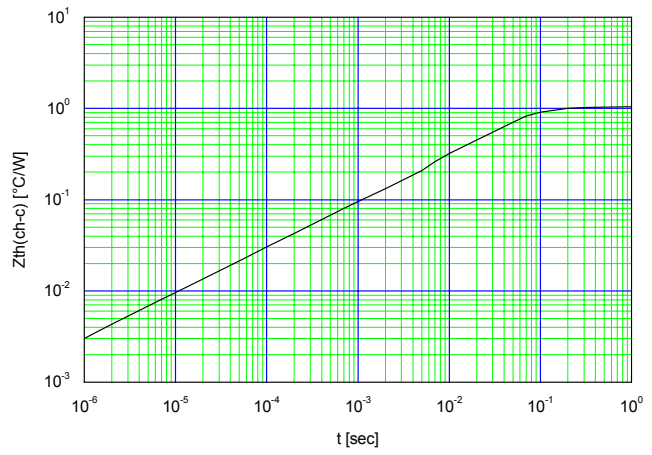




Maximum Avalanche Energy vs. starting Tch
 $E(AV)=f(\text{starting Tch}):V_{CC}=90V, I(AV)\leq 11A$



Maximum Transient Thermal Impedance
 $Z_{th(ch-c)}=f(t):D=0$



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